Sear	ch Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/467,712	AMIN ET AL.	
Examiner	Art Unit	
CongVan Tran	2617	

SEARCHED				
Class	Subclass	Date	Examiner	
455	41.2 522.1 553.1 556.1	6/6/2006	ст	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEAR (INCLUDING SE	CH NOTE	ES TRATEGY)
		DATE	EXMR
Search updated		6/6/2006	ст
			